## Search Notes



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Applicant(s)/Patent Under Reexamination
DEYN ET AL.

Examiner

Art Unit

Loewe, Sun Jae Y

1626

## **SEARCHED**

Class	Subclass	Date	Examiner

## **SEARCH NOTES**

Search Notes	Date	Examiner
restriction requirement	10-4-07	sl
restriction requirement	11-9-2007	sl
stn registry & caplus	1-28-2008	sl
palm all inventors	1-28-2008	sl
STN: registry & caplus updated	8-18-2008	sl
PALM all inventors updated	8-18-2008	sl
STN: registry & caplus updated	12-12-2008	sl
PALM all inventors updated	12-12-2008	sl
STN: registry & caplus updated	4-8-2009	sl
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INTERFERENCE SEARCH		
Code alloca	Data	

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